

Important notice

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Kind regards,

Team Nexperia



PDTB1xxxU series

500 mA, 50 V PNP resistor-equipped transistors

Rev. 1 — 6 May 2014

Product data sheet

1. Product profile

1.1 General description

PNP Resistor-Equipped Transistor (RET) family in a very small SOT323 (SC-70) Surface-Mounted Device (SMD) plastic package.

Table 1. Product overview

Type number	Package			NPN complement	Package configuration
	NXP	JEITA	JEDEC		
PDTB113EU	SOT323	SC-70	-	PDTD113EU	very small
PDTB113ZU				PDTD113ZU	
PDTB123EU				PDTD123EU	
PDTB123YU				PDTD123YU	
PDTB143EU				PDTD143EU	
PDTB143XU				PDTD143XU	
PDTB114EU				PDTD114EU	

1.2 Features

- 500 mA output current capability
- Built-in bias resistors
- Simplifies circuit design
- Reduces component count
- $\pm 10\%$ resistor ratio tolerance
- AEC-Q101 qualified
- High temperature applications up to 175 °C

1.3 Applications

- IC inputs control
- Cost-saving alternative to BC807 or BC817 series transistors in digital applications
- Switching loads



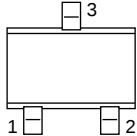
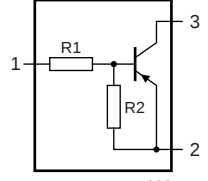
1.4 Quick reference data

Table 2. Quick reference data

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_{CEO}	collector-emitter voltage	open base	-	-	-50	V
I_O	output current		-	-	-500	mA
R1	bias resistor 1 (input)					
	PDTB113EU			1		k Ω
	PDTB113ZU			1		k Ω
	PDTB123EU			2.2		k Ω
	PDTB123YU			2.2		k Ω
	PDTB143EU			4.7		k Ω
	PDTB143XU			4.7		k Ω
	PDTB114EU			10		k Ω
R2	bias resistor 2 (base-emitter)					
	PDTB113EU			1		k Ω
	PDTB113ZU			10		k Ω
	PDTB123EU			2.2		k Ω
	PDTB123YU			10		k Ω
	PDTB143EU			4.7		k Ω
	PDTB143XU			10		k Ω
	PDTB114EU			10		k Ω

2. Pinning information

Table 3. Pinning

Pin	Description	Simplified outline	Graphic symbol
1	input (base)		 sym003
2	GND (emitter)		
3	output (collector)		

3. Ordering information

Table 4. Ordering information

Type number	Package		
	Name	Description	Version
PDTB1xxxU series	SC-70	plastic surface-mounted package; 3 leads	SOT323

4. Marking

Table 5. Marking codes

Type number	Marking code ^[1]
PDTB113EU	ZG*
PDTB113ZU	ZH*
PDTB123EU	ZJ*
PDTB123YU	ZK*
PDTB143EU	ZL*
PDTB143XU	ZM*
PDTB114EU	ZN*

[1] * = placeholder for manufacturing site code

5. Limiting values

Table 6. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{CBO}	collector-base voltage	open emitter	-	-50	V
V_{CEO}	collector-emitter voltage	open base	-	-50	V
V_{EBO}	emitter-base voltage	open collector			
	PDTB113EU		-	-10	V
	PDTB113ZU		-	-5	V
	PDTB123EU		-	-10	V
	PDTB123YU		-	-5	V
	PDTB143EU		-	-10	V
	PDTB143XU		-	-7	V
	PDTB114EU		-	-10	V
V_i	input voltage				
	PDTB113EU		-10	+10	V
	PDTB113ZU		-10	+5	V
	PDTB123EU		-12	+10	V
	PDTB123YU		-12	+5	V
	PDTB143EU		-30	+10	V
	PDTB143XU		-30	+7	V
	PDTB114EU		-50	+10	V
I_o	output current		-	-500	mA

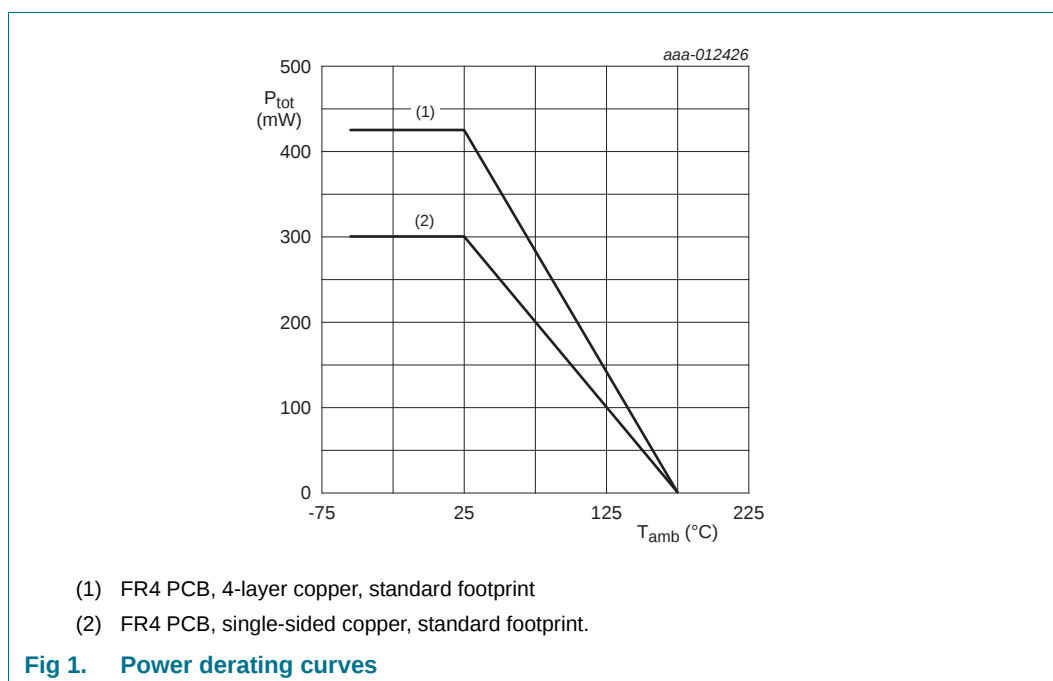
Table 6. Limiting values ...continued

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
P _{tot}	total power dissipation	T _{amb} ≤ 25 °C [1]	-	300	mW
		[2]	-	425	mW
T _j	junction temperature		-	175	°C
T _{amb}	ambient temperature		-55	+175	°C
T _{stg}	storage temperature		-55	+175	°C

[1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.

[2] Device mounted on an FR4 PCB, 4-layer copper, tin-plated and standard footprint.

**Fig 1.** Power derating curves

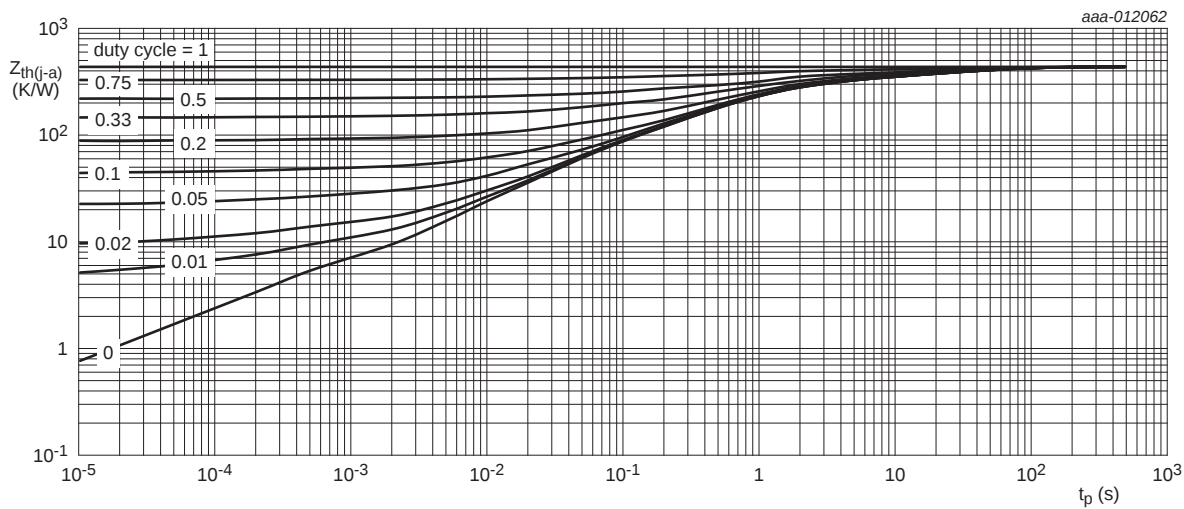
6. Thermal characteristics

Table 7. Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
R _{th(j-a)}	thermal resistance from junction to ambient	in free air [1]	-	-	500	K/W
		[2]	-	-	353	K/W

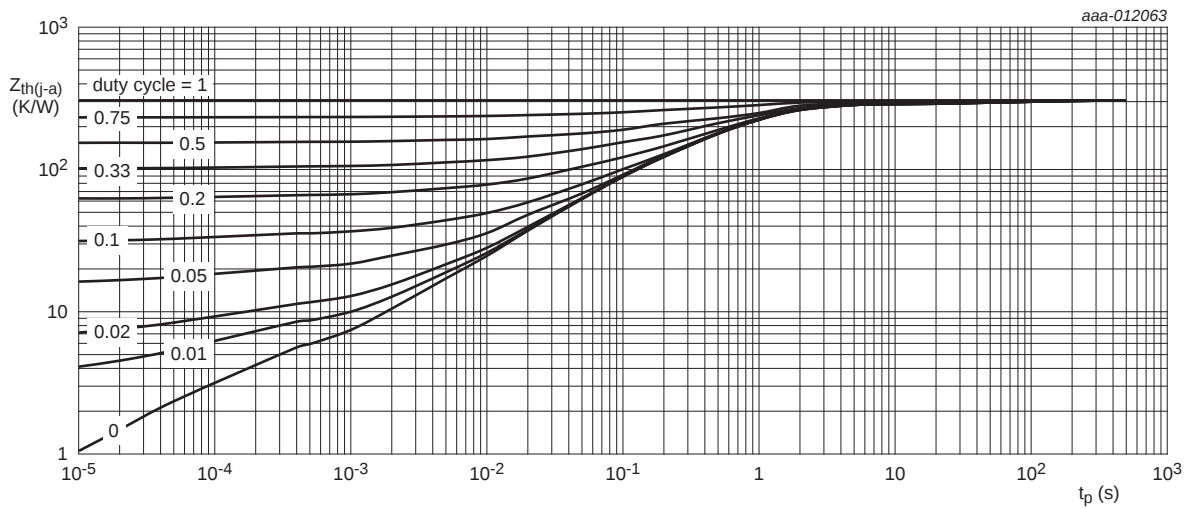
[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

[2] Device mounted on an FR4 PCB, 4-layer copper, tin-plated and standard footprint.



FR4 PCB, single-sided copper, tin-plated and standard footprint

Fig 2. Transient thermal impedance from junction to ambient as a function of pulse duration for SOT323/SC-70; typical values



FR4 PCB, 4-layer copper, tin-plated and standard footprint.

Fig 3. Transient thermal impedance from junction to ambient as a function of pulse duration for SOT323/SC-70; typical values

7. Characteristics

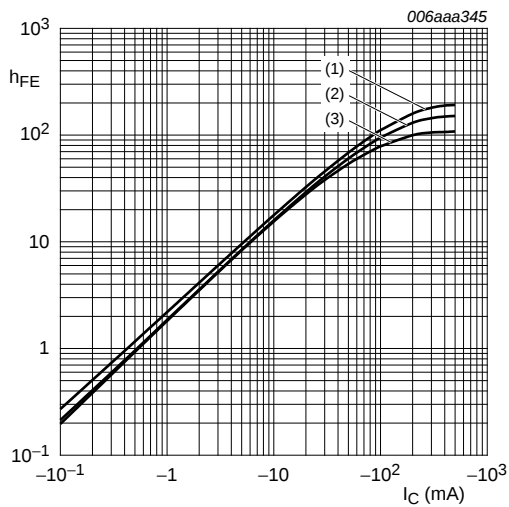
Table 8. Characteristics
 $T_{amb} = 25\text{ }^{\circ}\text{C}$ unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
I_{CBO}	collector-base cut-off current	$V_{CB} = -40\text{ V}; I_E = 0\text{ A}$	-	-	-100	nA
		$V_{CB} = -50\text{ V}; I_E = 0\text{ A}$	-	-	-100	nA
I_{CEO}	collector-emitter cut-off current	$V_{CE} = -50\text{ V}; I_B = 0\text{ A}$	-	-	-0.5	μA
I_{EBO}	emitter-base cut-off current	$V_{EB} = -5\text{ V}; I_C = 0\text{ A}$				
	PDTB113EU		-	-	-4.0	mA
	PDTB113ZU		-	-	-0.8	mA
	PDTB123EU		-	-	-2.0	mA
	PDTB123YU		-	-	-0.65	mA
	PDTB143EU		-	-	-0.9	mA
	PDTB143XU		-	-	-0.6	mA
	PDTB114EU		-	-	-0.4	mA
h_{FE}	DC current gain	$V_{CE} = -5\text{ V}; I_C = -50\text{ mA}$				
	PDTB113EU		33	-	-	
	PDTB113ZU		70	-	-	
	PDTB123EU		40	-	-	
	PDTB123YU		70	-	-	
	PDTB143EU		60	-	-	
	PDTB143XU		70	-	-	
	PDTB114EU		70	-	-	
V_{CEsat}	collector-emitter saturation voltage	$I_C = -50\text{ mA}; I_B = -2.5\text{ mA}$	-	-	-100	mV
$V_{I(off)}$	off-state input voltage	$V_{CE} = -5\text{ V}; I_C = -100\text{ }\mu\text{A}$				
	PDTB113EU		-0.6	-1.0	-1.5	V
	PDTB113ZU		-0.3	-0.6	-1.0	V
	PDTB123EU		-0.6	-1.1	-1.8	V
	PDTB123YU		-0.4	-0.65	-1.0	V
	PDTB143EU		-0.6	-0.9	-1.5	V
	PDTB143XU		-0.5	-0.75	-1.1	V
	PDTB114EU		-0.6	-1.0	-1.5	V
$V_{I(on)}$	on-state input voltage	$V_{CE} = -0.3\text{ V}; I_C = -20\text{ mA}$				
	PDTB113EU		-1.0	-1.4	-1.8	V
	PDTB113ZU		-0.4	-0.8	-1.4	V
	PDTB123EU		-1.0	-1.5	-2.0	V
	PDTB123YU		-0.5	-1.0	-1.4	V
	PDTB143EU		-1.0	-1.7	-2.2	V
	PDTB143XU		-1.0	-1.4	-2.0	V
	PDTB114EU		-1.0	-2.2	-3.0	V

Table 8. Characteristics ...continued
 $T_{amb} = 25\text{ }^{\circ}\text{C}$ unless otherwise specified.

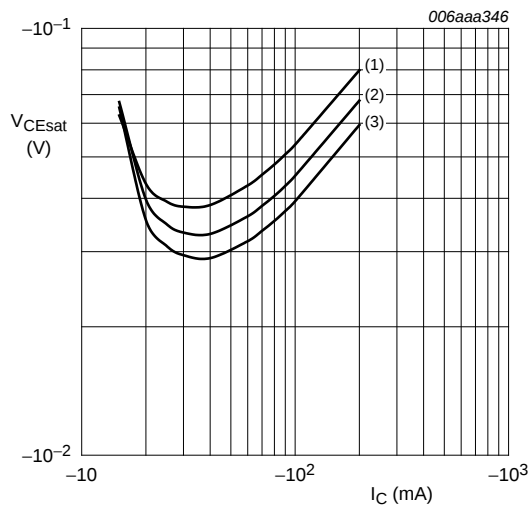
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
R1	bias resistor 1 (input)					
	PDTB113EU		0.7	1.0	1.3	k Ω
	PDTB113ZU		0.7	1.0	1.3	k Ω
	PDTB123EU		1.54	2.2	2.86	k Ω
	PDTB123YU		1.54	2.2	2.86	k Ω
	PDTB143EU		3.3	4.7	6.1	k Ω
	PDTB143XU		3.3	4.7	6.1	k Ω
	PDTB114EU		7.0	10	13	k Ω
R2/R1	bias resistor ratio					
	PDTB113EU		0.9	1.0	1.1	
	PDTB113ZU		9.0	10	11	
	PDTB123EU		0.9	1.0	1.1	
	PDTB123YU		4.1	4.55	5.0	
	PDTB143EU		0.9	1	1.1	
	PDTB143XU		1.91	2.13	2.34	
	PDTB114EU		0.9	1.0	1.1	
C_c	collector capacitance	$V_{CB} = -10\text{ V};$ $I_E = I_C = 0\text{ A}; f = 1\text{ MHz}$	-	11	-	pF
f_T	transition frequency	$V_{CE} = -5\text{ V};$ $I_C = -50\text{ mA};$ $f = 100\text{ MHz}$	[1]	140	-	MHz

[1] Characteristics of built-in transistor.



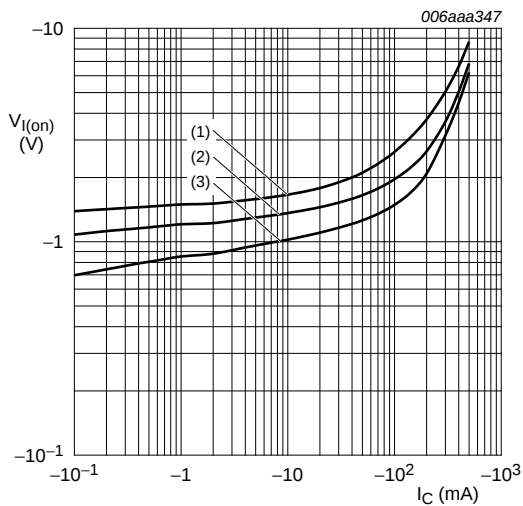
$V_{CE} = -5\text{ V}$
(1) $T_{amb} = 100^\circ\text{C}$
(2) $T_{amb} = 25^\circ\text{C}$
(3) $T_{amb} = -40^\circ\text{C}$

Fig 4. PDTB113EU: DC current gain as a function of collector current; typical values



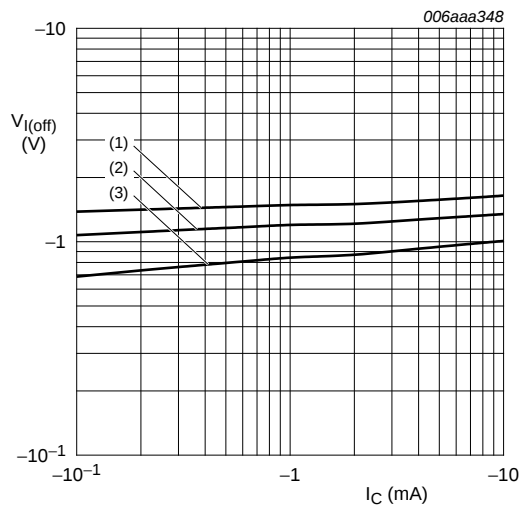
$I_C/I_B = 20$
(1) $T_{amb} = 100^\circ\text{C}$
(2) $T_{amb} = 25^\circ\text{C}$
(3) $T_{amb} = -40^\circ\text{C}$

Fig 5. PDTB113EU: Collector-emitter saturation voltage as a function of collector current; typical values



$V_{CE} = -0.3\text{ V}$
(1) $T_{amb} = -40^\circ\text{C}$
(2) $T_{amb} = 25^\circ\text{C}$
(3) $T_{amb} = 100^\circ\text{C}$

Fig 6. PDTB113EU: On-state input voltage as a function of collector current; typical values



$V_{CE} = -5\text{ V}$
(1) $T_{amb} = -40^\circ\text{C}$
(2) $T_{amb} = 25^\circ\text{C}$
(3) $T_{amb} = 100^\circ\text{C}$

Fig 7. PDTB113EU: Off-state input voltage as a function of collector current; typical values

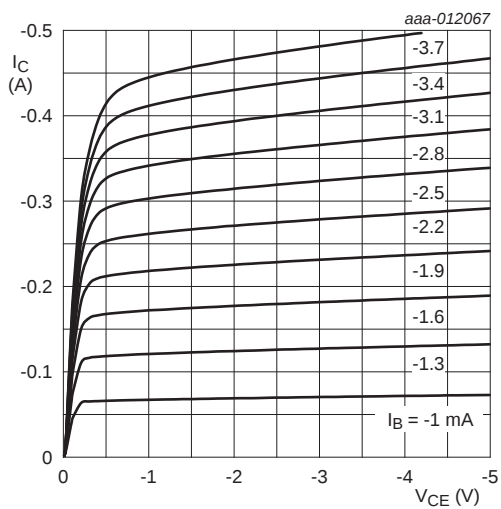


Fig 8. PDTB113EU: Collector current as a function of collector-emitter voltage; typical values

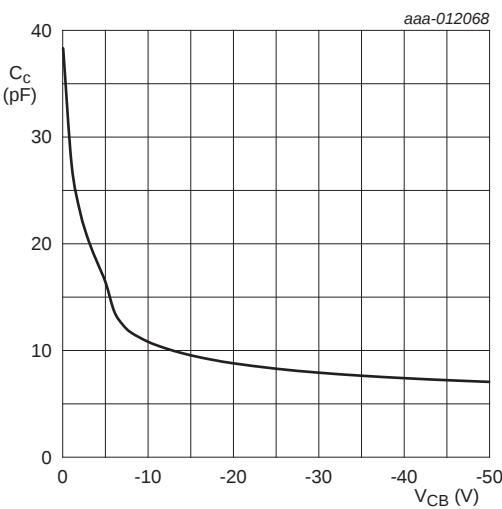


Fig 9. PDTB113EU: Collector capacitance as a function of collector-base voltage; typical values

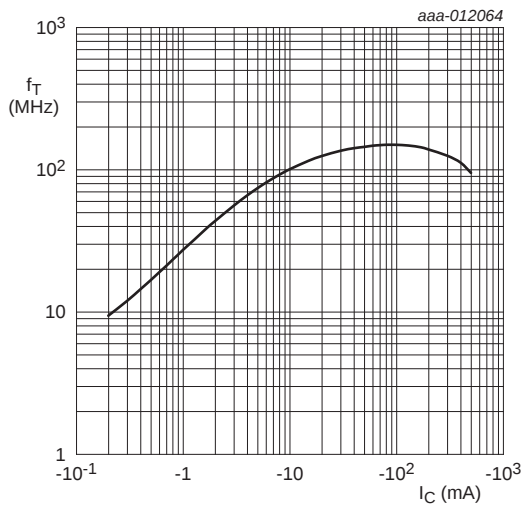
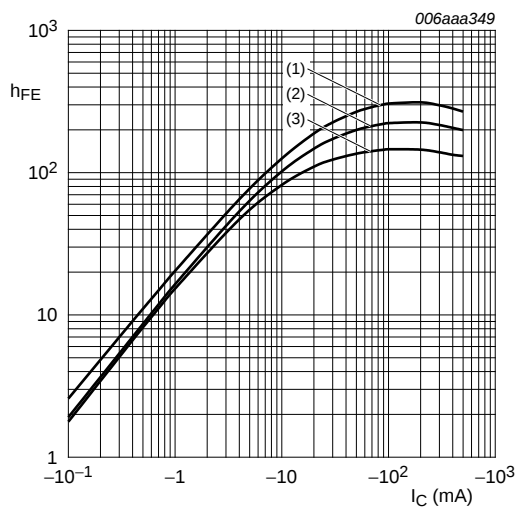
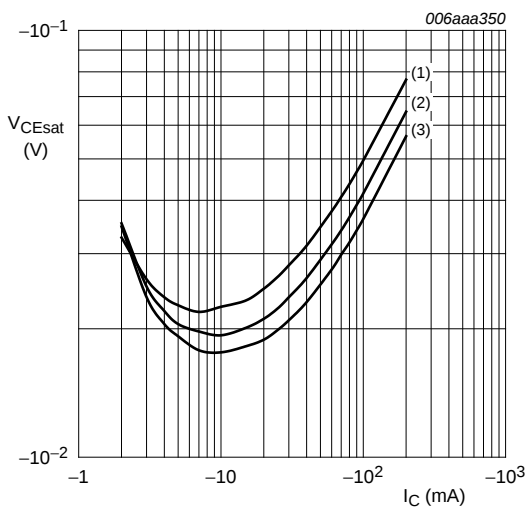


Fig 10. PDTB113EU: Transition frequency as a function of collector current; typical values of built-in transistor



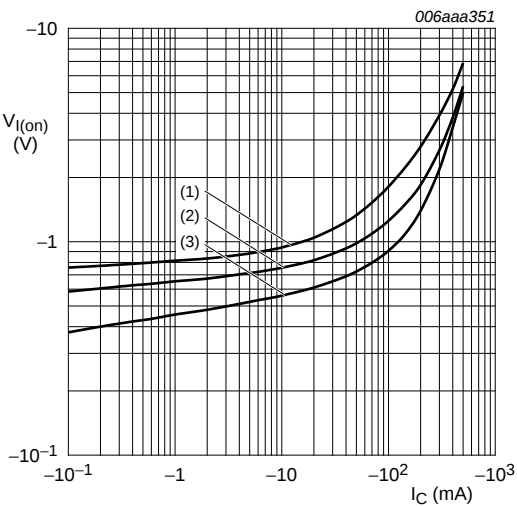
- $V_{CE} = -5\text{ V}$
- (1) $T_{amb} = 100^\circ\text{C}$
 - (2) $T_{amb} = 25^\circ\text{C}$
 - (3) $T_{amb} = -40^\circ\text{C}$

Fig 11. PDTB113ZU: DC current gain as a function of collector current; typical values



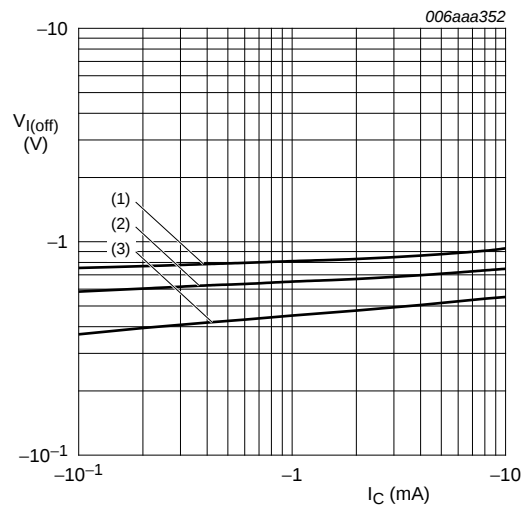
- $I_C/I_B = 20$
- (1) $T_{amb} = 100^\circ\text{C}$
 - (2) $T_{amb} = 25^\circ\text{C}$
 - (3) $T_{amb} = -40^\circ\text{C}$

Fig 12. PDTB113ZU: Collector-emitter saturation voltage as a function of collector current; typical values



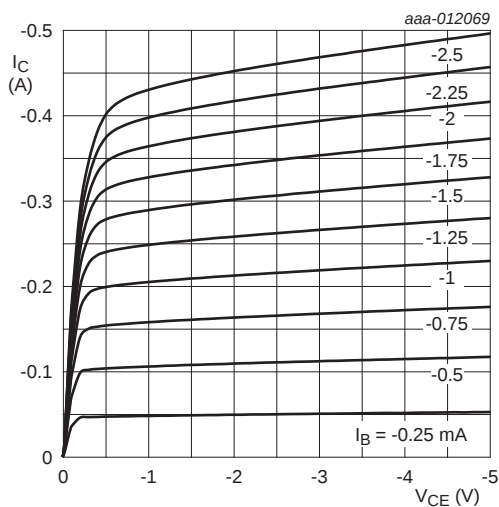
- $V_{CE} = -0.3\text{ V}$
- (1) $T_{amb} = -40^\circ\text{C}$
 - (2) $T_{amb} = 25^\circ\text{C}$
 - (3) $T_{amb} = 100^\circ\text{C}$

Fig 13. PDTB113ZU: On-state input voltage as a function of collector current; typical values



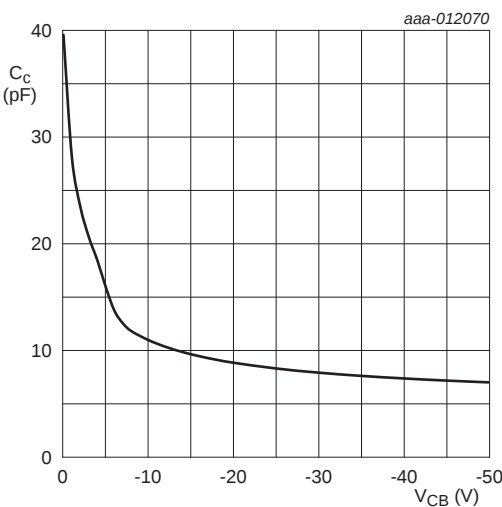
- $V_{CE} = -5\text{ V}$
- (1) $T_{amb} = -40^\circ\text{C}$
 - (2) $T_{amb} = 25^\circ\text{C}$
 - (3) $T_{amb} = 100^\circ\text{C}$

Fig 14. PDTB113ZU: Off-state input voltage as a function of collector current; typical values



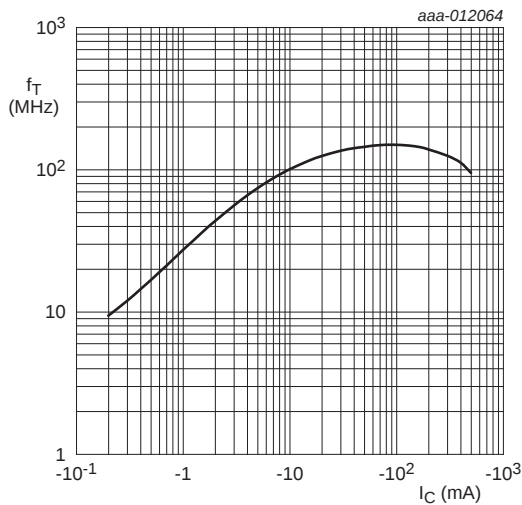
$T_{amb} = 25\text{ °C}$

Fig 15. PDTB113ZU: Collector current as a function of collector-emitter voltage; typical values



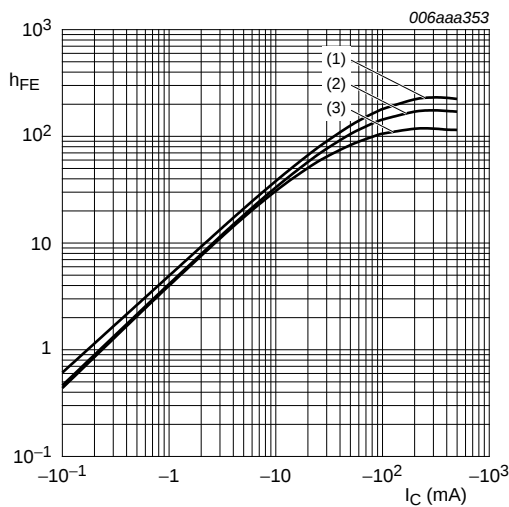
$f = 1\text{ MHz}; T_{amb} = 25\text{ °C}$

Fig 16. PDTB113ZU: Collector capacitance as a function of collector-base voltage; typical values



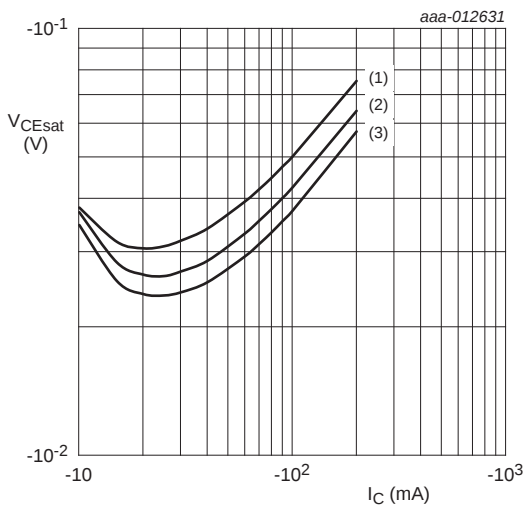
$V_{CE} = -5\text{ V}; T_{amb} = 25\text{ °C}$

Fig 17. PDTB113ZU: Transition frequency as a function of collector current; typical values of built-in transistor



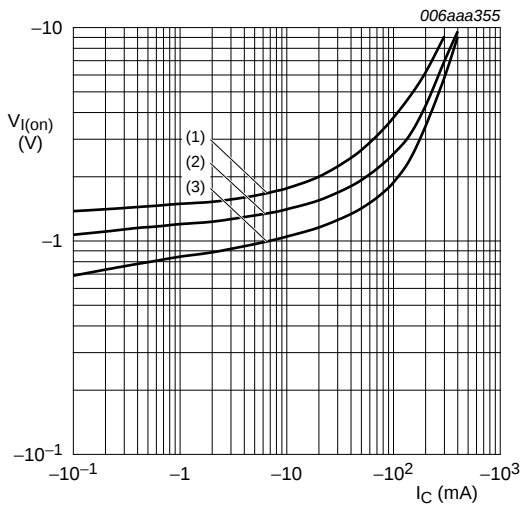
- $V_{CE} = -5$ V
- (1) $T_{amb} = 100$ °C
 - (2) $T_{amb} = 25$ °C
 - (3) $T_{amb} = -40$ °C

Fig 18. PDTB123EU: DC current gain as a function of collector current; typical values



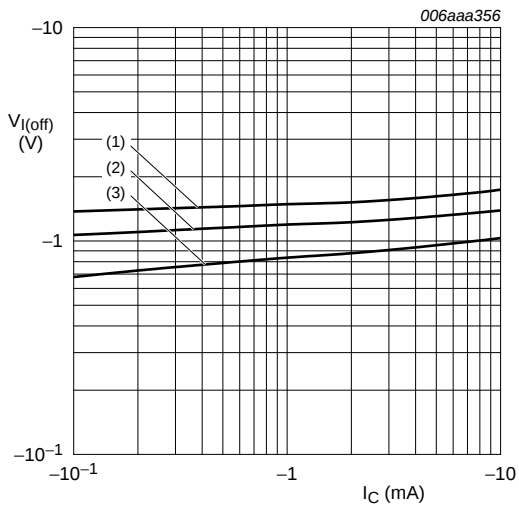
- $I_C/I_B = 20$
- (1) $T_{amb} = 100$ °C
 - (2) $T_{amb} = 25$ °C
 - (3) $T_{amb} = -40$ °C

Fig 19. PDTB123EU: Collector-emitter saturation voltage as a function of collector current; typical values



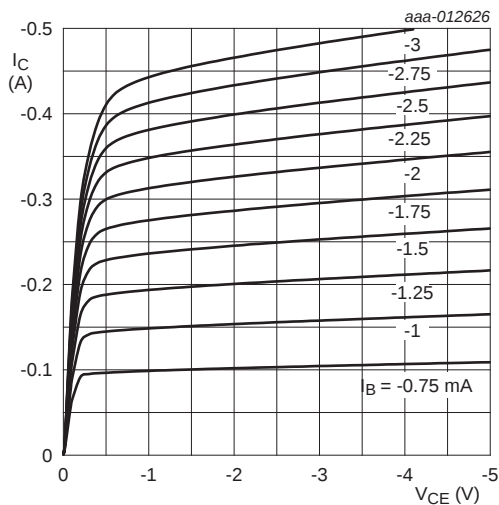
- $V_{CE} = -0.3$ V
- (1) $T_{amb} = -40$ °C
 - (2) $T_{amb} = 25$ °C
 - (3) $T_{amb} = 100$ °C

Fig 20. PDTB123EU: On-state input voltage as a function of collector current; typical values



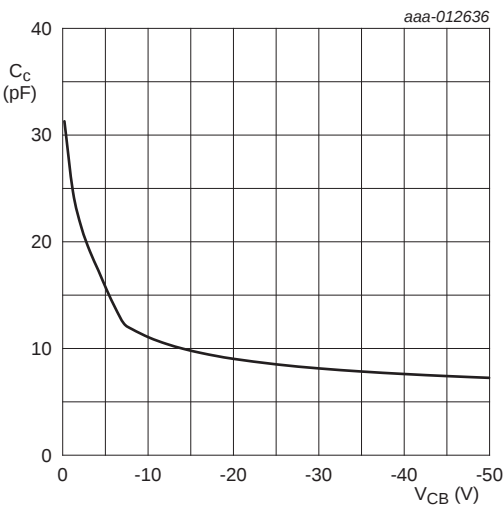
- $V_{CE} = -5$ V
- (1) $T_{amb} = -40$ °C
 - (2) $T_{amb} = 25$ °C
 - (3) $T_{amb} = 100$ °C

Fig 21. PDTB123EU: Off-state input voltage as a function of collector current; typical values



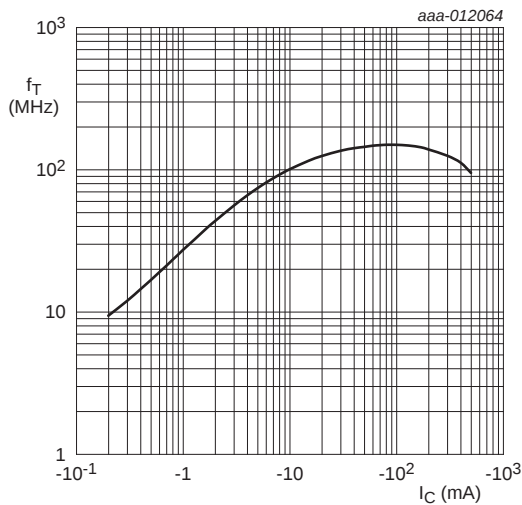
$T_{amb} = 25\text{ °C}$

Fig 22. PDTB123EU: Collector current as a function of collector-emitter voltage; typical values



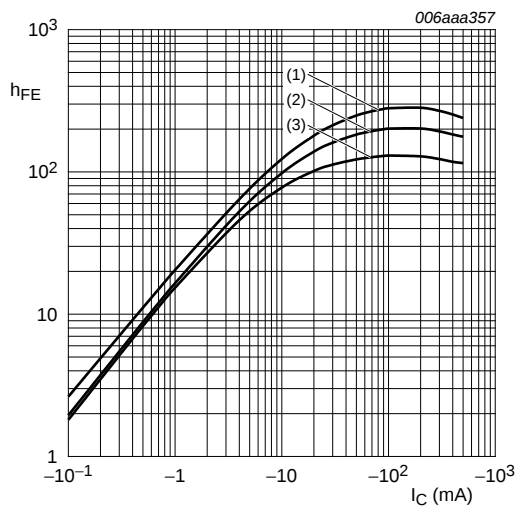
$f = 1\text{ MHz}; T_{amb} = 25\text{ °C}$

Fig 23. PDTB123EU: Collector capacitance as a function of collector-base voltage; typical values



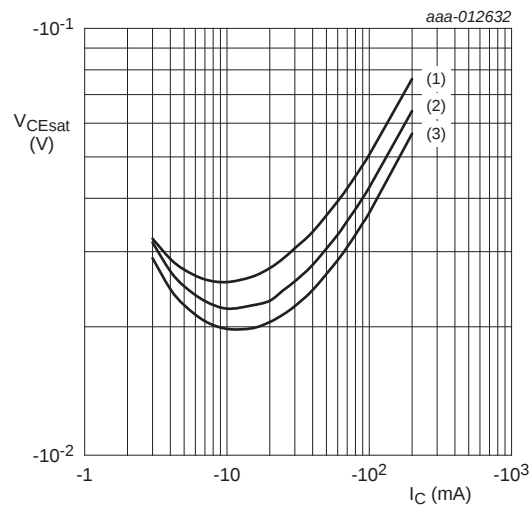
$V_{CE} = -5\text{ V}; T_{amb} = 25\text{ °C}$

Fig 24. PDTB123EU: Transition frequency as a function of collector current; typical values of built-in transistor



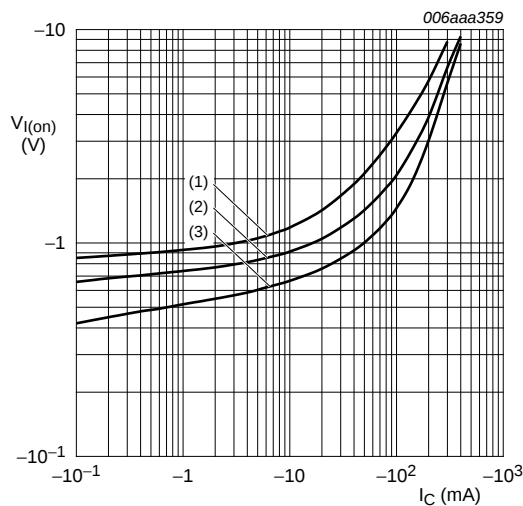
- $V_{CE} = -5\text{ V}$
- (1) $T_{amb} = 100^\circ\text{C}$
 - (2) $T_{amb} = 25^\circ\text{C}$
 - (3) $T_{amb} = -40^\circ\text{C}$

Fig 25. PDTB123YU: DC current gain as a function of collector current; typical values



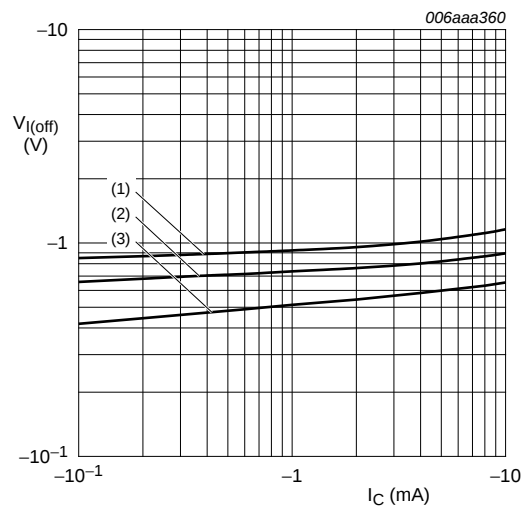
- $I_C/I_B = 20$
- (1) $T_{amb} = 100^\circ\text{C}$
 - (2) $T_{amb} = 25^\circ\text{C}$
 - (3) $T_{amb} = -40^\circ\text{C}$

Fig 26. PDTB123YU: Collector-emitter saturation voltage as a function of collector current; typical values



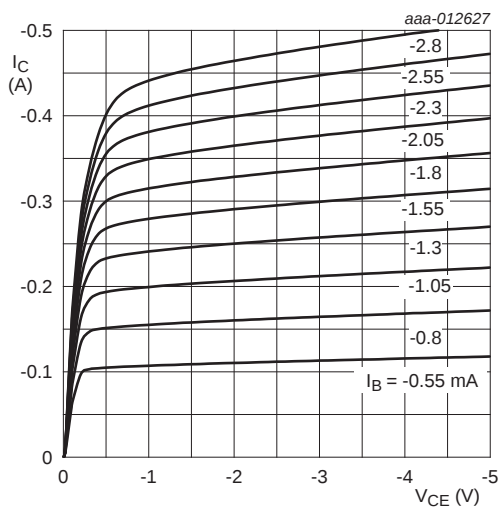
- $V_{CE} = -0.3\text{ V}$
- (1) $T_{amb} = -40^\circ\text{C}$
 - (2) $T_{amb} = 25^\circ\text{C}$
 - (3) $T_{amb} = 100^\circ\text{C}$

Fig 27. PDTB123YU: On-state input voltage as a function of collector current; typical values



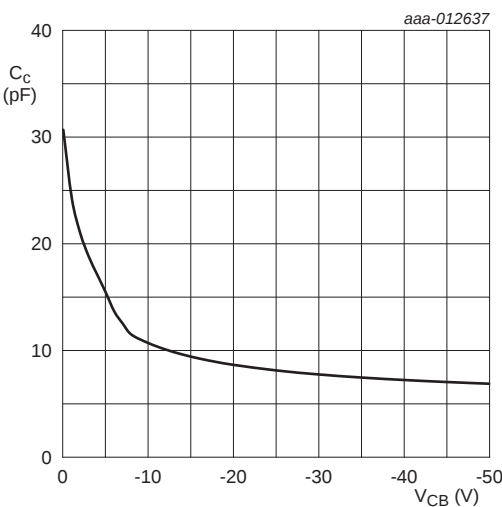
- $V_{CE} = -5\text{ V}$
- (1) $T_{amb} = -40^\circ\text{C}$
 - (2) $T_{amb} = 25^\circ\text{C}$
 - (3) $T_{amb} = 100^\circ\text{C}$

Fig 28. PDTB123YU: Off-state input voltage as a function of collector current; typical values



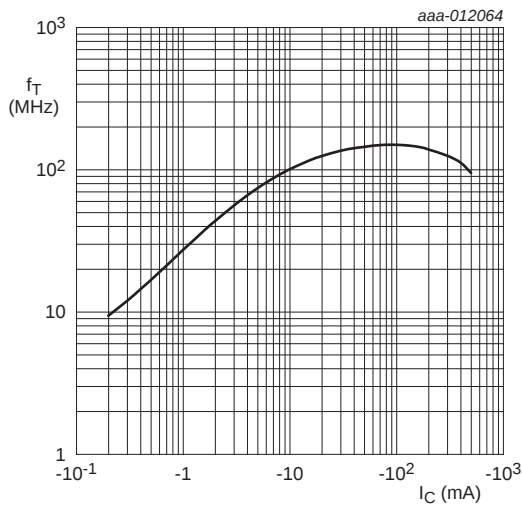
$T_{amb} = 25\text{ °C}$

Fig 29. PDTB123YU: Collector current as a function of collector-emitter voltage; typical values



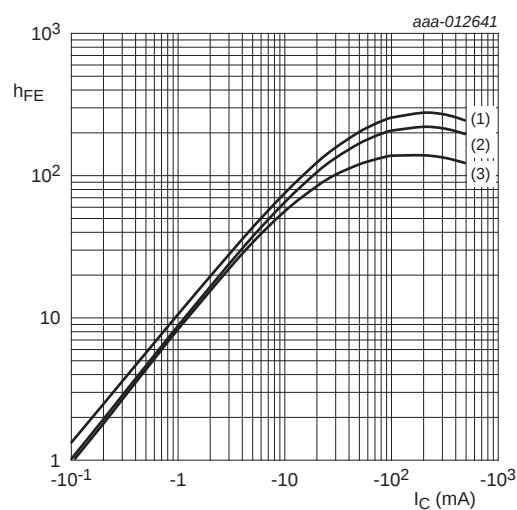
$f = 1\text{ MHz}; T_{amb} = 25\text{ °C}$

Fig 30. PDTB123YU: Collector capacitance as a function of collector-base voltage; typical values



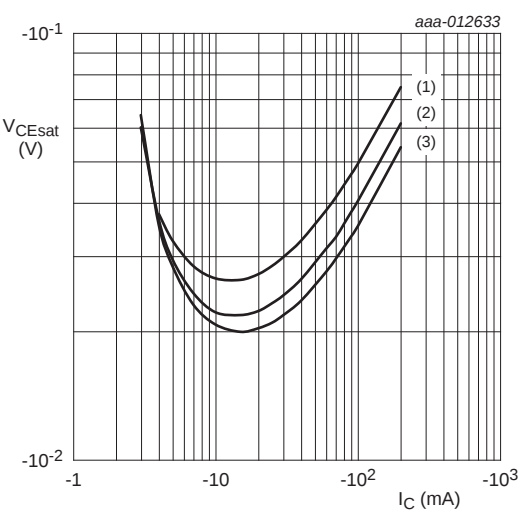
$V_{CE} = -5\text{ V}; T_{amb} = 25\text{ °C}$

Fig 31. PDTB123YU: Transition frequency as a function of collector current; typical values of built-in transistor



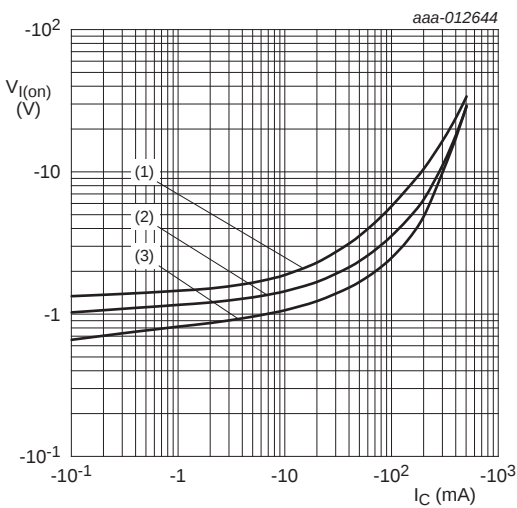
$V_{CE} = -5$ V
(1) $T_{amb} = 100$ °C
(2) $T_{amb} = 25$ °C
(3) $T_{amb} = -40$ °C

Fig 32. PDTB143EU: DC current gain as a function of collector current; typical values



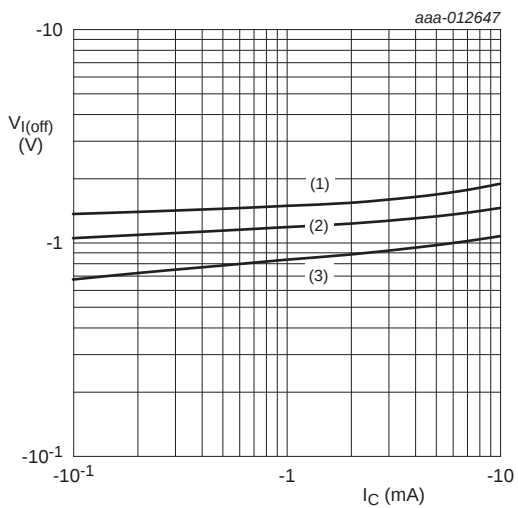
$I_C/I_B = 20$
(1) $T_{amb} = 100$ °C
(2) $T_{amb} = 25$ °C
(3) $T_{amb} = -40$ °C

Fig 33. PDTB143EU: Collector-emitter saturation voltage as a function of collector current; typical values



$V_{CE} = -0.3$ V
(1) $T_{amb} = -40$ °C
(2) $T_{amb} = 25$ °C
(3) $T_{amb} = 100$ °C

Fig 34. PDTB143EU: On-state input voltage as a function of collector current; typical values



$V_{CE} = -5$ V
(1) $T_{amb} = -40$ °C
(2) $T_{amb} = 25$ °C
(3) $T_{amb} = 100$ °C

Fig 35. PDTB143EU: Off-state input voltage as a function of collector current; typical values

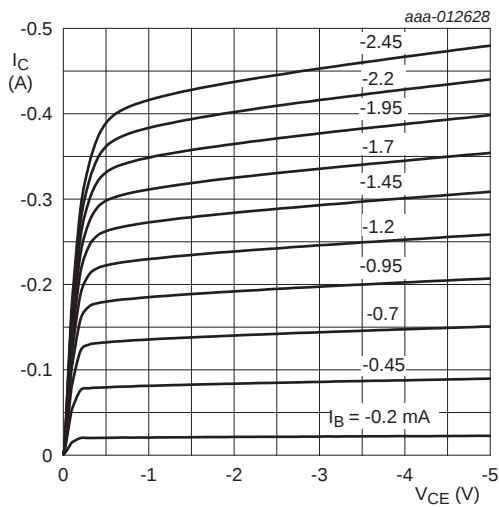


Fig 36. PDTB143EU: Collector current as a function of collector-emitter voltage; typical values

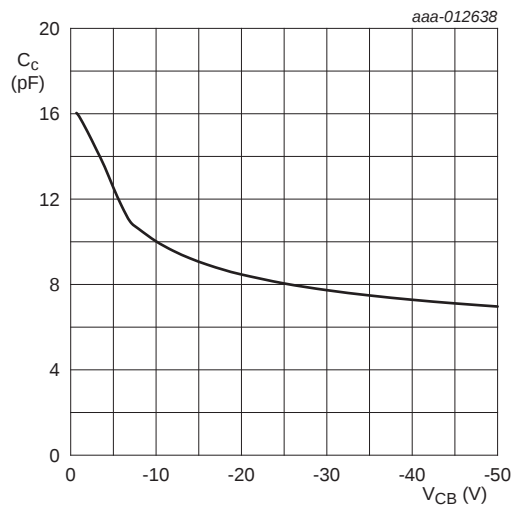


Fig 37. PDTB143EU: Collector capacitance as a function of collector-base voltage; typical values

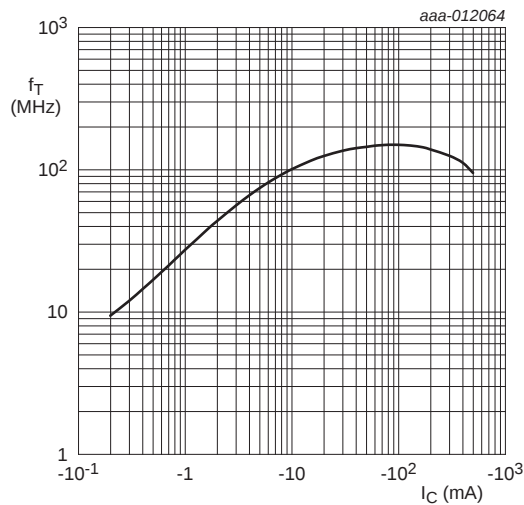
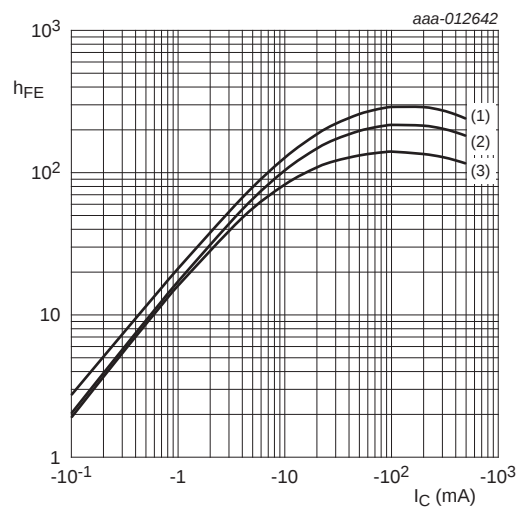
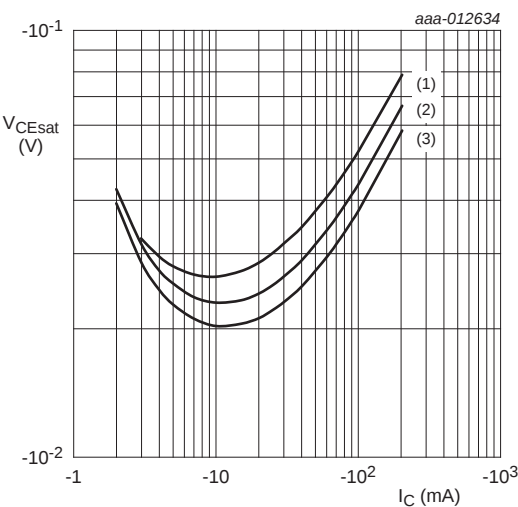


Fig 38. PDTB143EU: Transition frequency as a function of collector current; typical values of built-in transistor



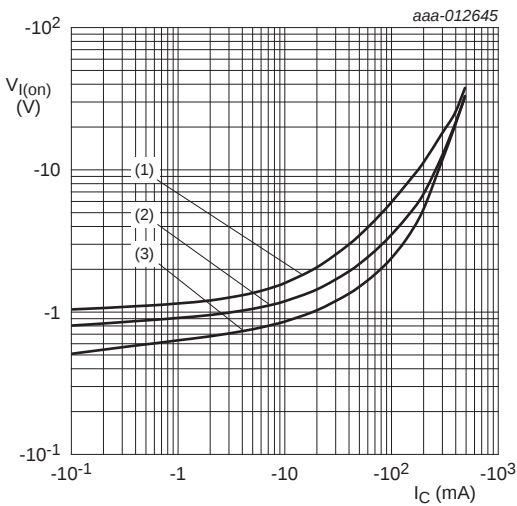
- $V_{CE} = -5$ V
- (1) $T_{amb} = 100$ °C
 - (2) $T_{amb} = 25$ °C
 - (3) $T_{amb} = -40$ °C

Fig 39. PDTB143XU: DC current gain as a function of collector current; typical values



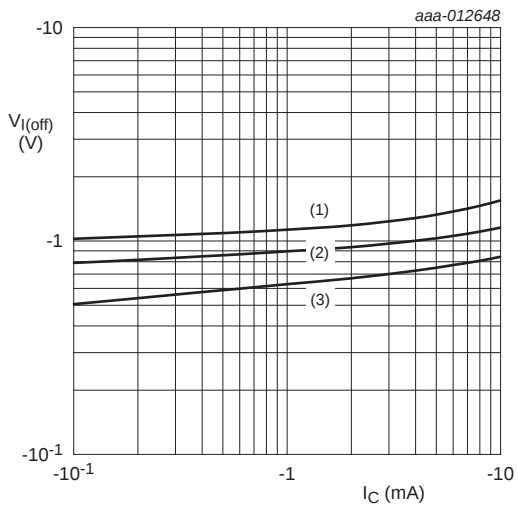
- $I_C/I_B = 20$
- (1) $T_{amb} = 100$ °C
 - (2) $T_{amb} = 25$ °C
 - (3) $T_{amb} = -40$ °C

Fig 40. PDTB143XU: Collector-emitter saturation voltage as a function of collector current; typical values



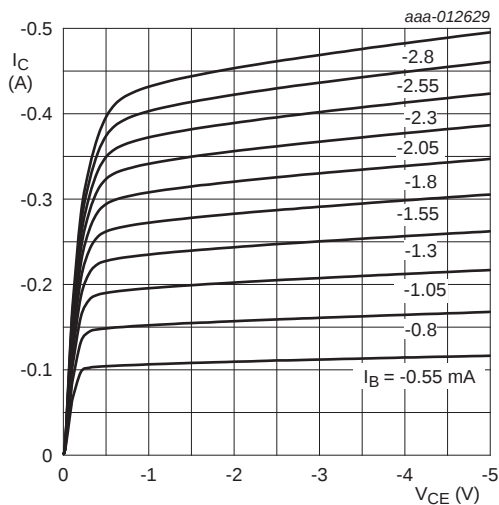
- $V_{CE} = -0.3$ V
- (1) $T_{amb} = -40$ °C
 - (2) $T_{amb} = 25$ °C
 - (3) $T_{amb} = 100$ °C

Fig 41. PDTB143XU: On-state input voltage as a function of collector current; typical values



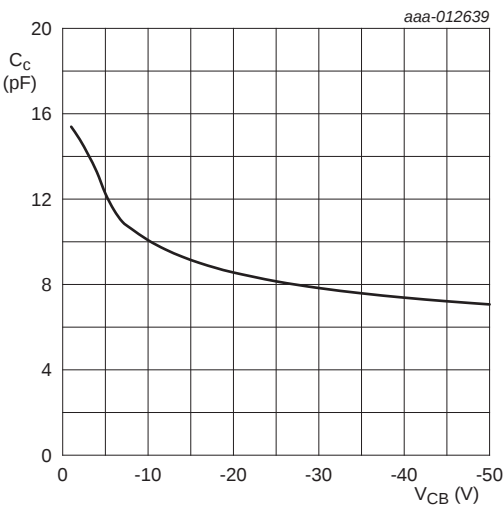
- $V_{CE} = -5$ V
- (1) $T_{amb} = -40$ °C
 - (2) $T_{amb} = 25$ °C
 - (3) $T_{amb} = 100$ °C

Fig 42. PDTB143XU: Off-state input voltage as a function of collector current; typical values



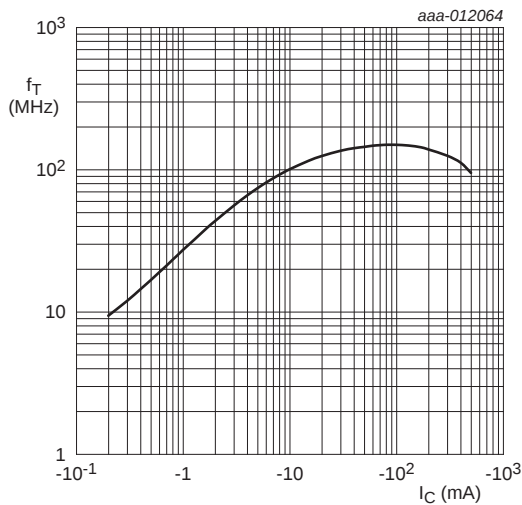
$T_{amb} = 25\text{ }^{\circ}\text{C}$

Fig 43. PDTB143XU: Collector current as a function of collector-emitter voltage; typical values



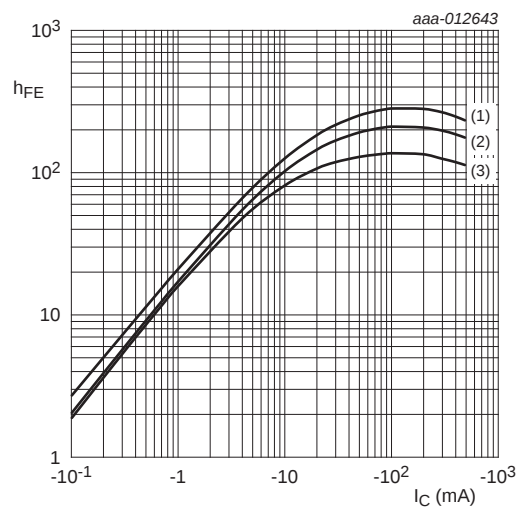
$f = 1 \text{ MHz}; T_{amb} = 25\text{ }^{\circ}\text{C}$

Fig 44. PDTB143XU: Collector capacitance as a function of collector-base voltage; typical values



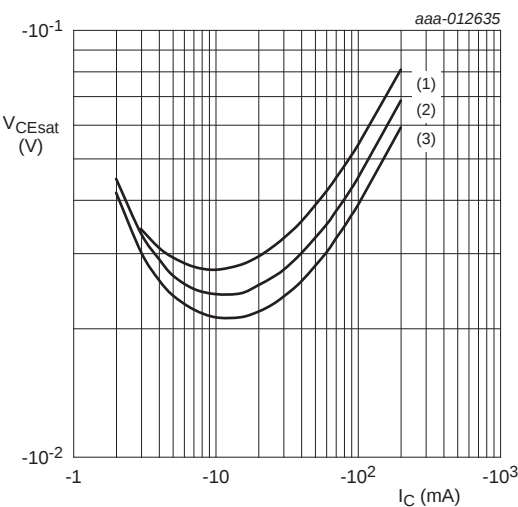
$V_{CE} = -5 \text{ V}; T_{amb} = 25\text{ }^{\circ}\text{C}$

Fig 45. PDTB143XU: Transition frequency as a function of collector current; typical values of built-in transistor



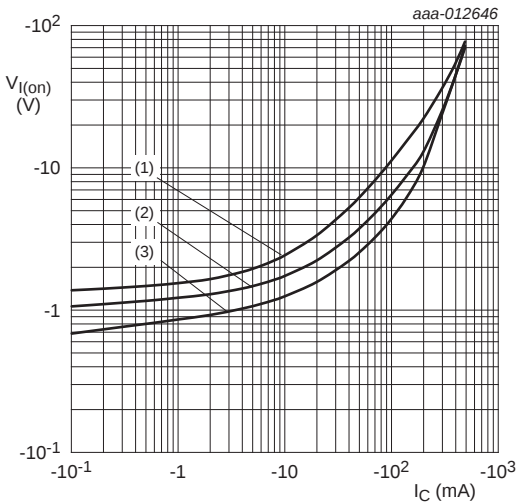
$V_{CE} = -5$ V
(1) $T_{amb} = 100$ °C
(2) $T_{amb} = 25$ °C
(3) $T_{amb} = -40$ °C

Fig 46. PDTB114EU: DC current gain as a function of collector current; typical values



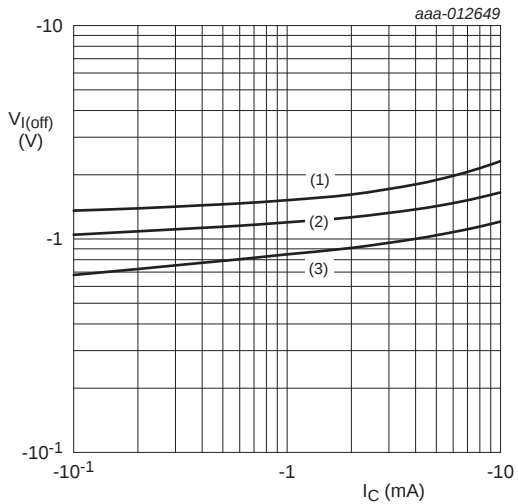
$I_C/I_B = 20$
(1) $T_{amb} = 100$ °C
(2) $T_{amb} = 25$ °C
(3) $T_{amb} = -40$ °C

Fig 47. PDTB114EU: Collector-emitter saturation voltage as a function of collector current; typical values



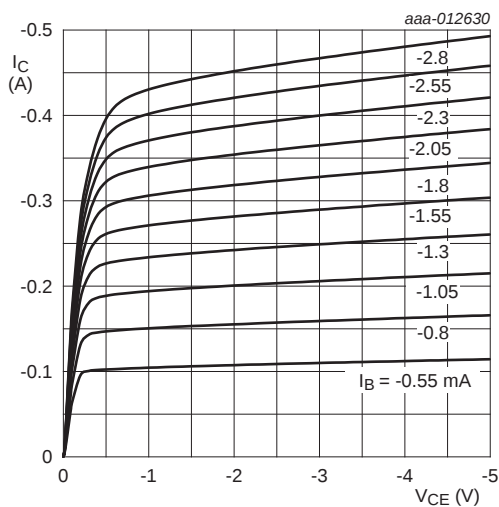
$V_{CE} = -0.3$ V
(1) $T_{amb} = -40$ °C
(2) $T_{amb} = 25$ °C
(3) $T_{amb} = 100$ °C

Fig 48. PDTB114EU: On-state input voltage as a function of collector current; typical values



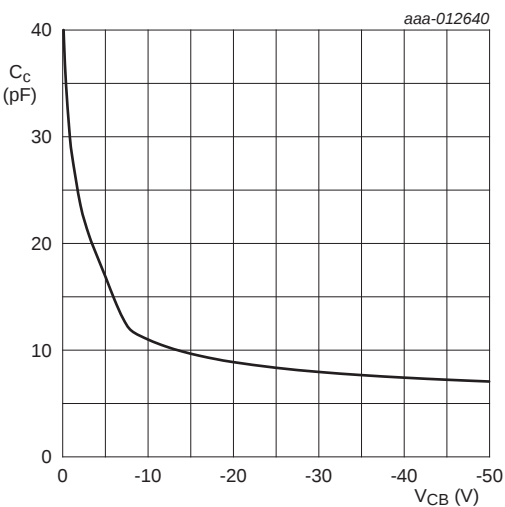
$V_{CE} = -5$ V
(1) $T_{amb} = -40$ °C
(2) $T_{amb} = 25$ °C
(3) $T_{amb} = 100$ °C

Fig 49. PDTB114EU: Off-state input voltage as a function of collector current; typical values



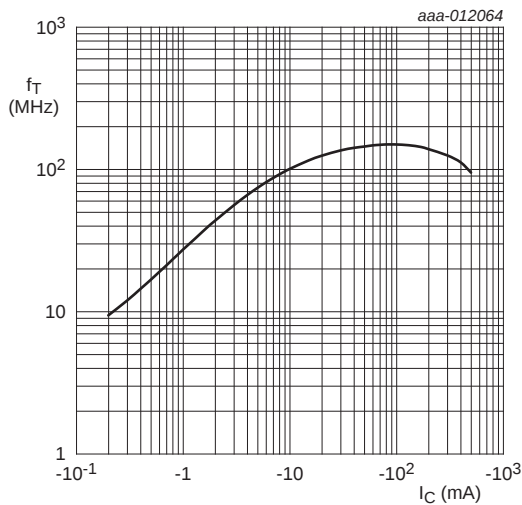
$T_{amb} = 25\text{ }^{\circ}\text{C}$

Fig 50. PDTB114EU: Collector current as a function of collector-emitter voltage; typical values



$f = 1 \text{ MHz}; T_{amb} = 25\text{ }^{\circ}\text{C}$

Fig 51. PDTB114EU: Collector capacitance as a function of collector-base voltage; typical values of built-in transistor



$V_{CE} = -5 \text{ V}; T_{amb} = 25\text{ }^{\circ}\text{C}$

Fig 52. PDTB114EU: Transition frequency as a function of collector current; typical values of built-in transistor

8. Test information

8.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard *Q101 - Stress test qualification for discrete semiconductors*, and is suitable for use in automotive applications.

9. Package outline

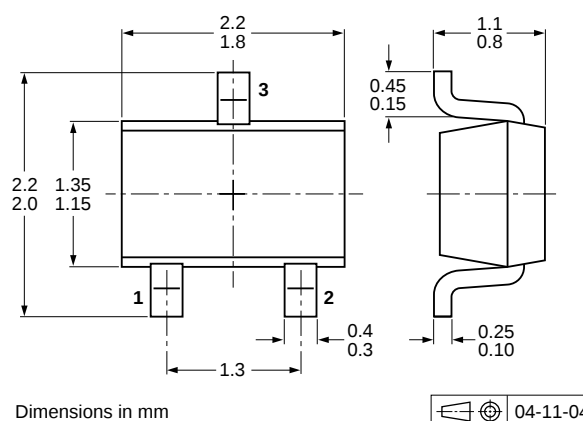


Fig 53. Package outline PDTB1xxxU series (SOT323/SC-70)

10. Soldering

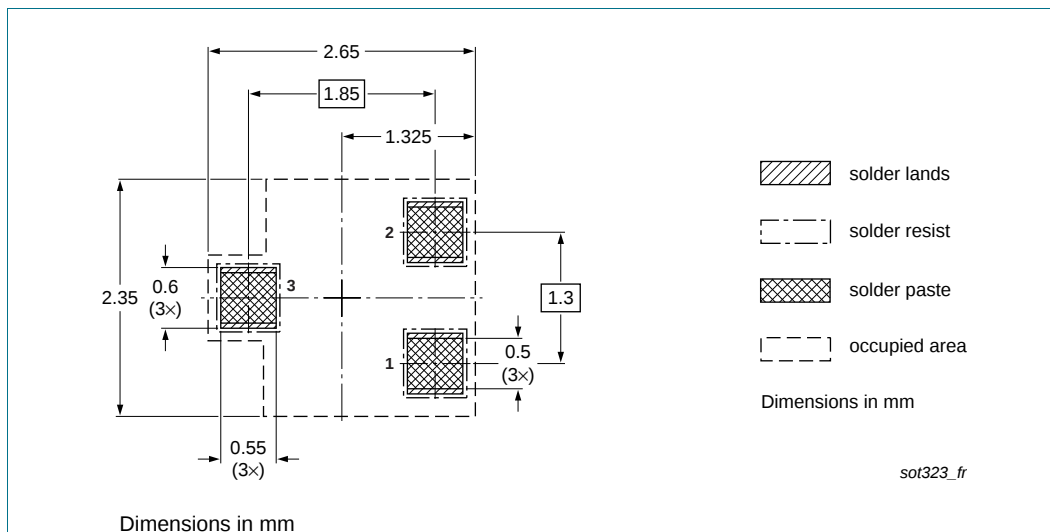


Fig 54. Reflow soldering footprint PDTB1xxxU series (SOT323/SC-70)

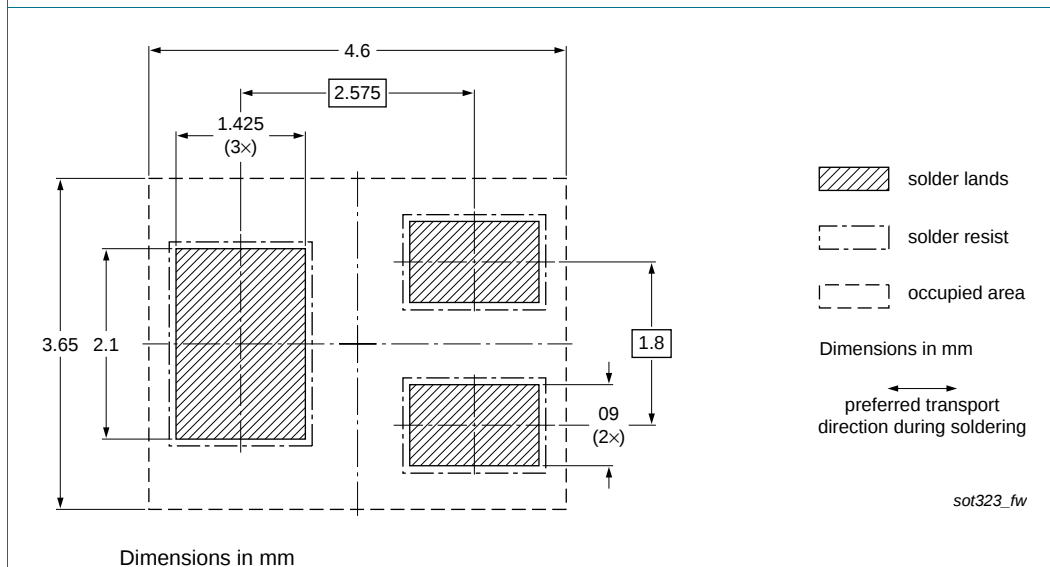


Fig 55. Wave soldering footprint PDTB1xxxU series (SOT323/SC-70)

11. Revision history

Table 9. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PDTB1XXXU_SER v.1	20140506	Product data sheet	-	-

12. Legal information

12.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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